

Notice of References Cited	Application/Control No. 10/826,391	Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL.	
	Examiner Matthew Landau	Art Unit 2815	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0048855	04-2002	Matsudai et al.	438/135
*	B	US-5,270,230	12-1993	Sakurai, Kenya	438/141
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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